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December 2014

## FODM8071 3.3V/5V Logic Gate Output Optocoupler with **High Noise Immunity**

#### **Features**

- High-noise Immunity Characterized by Common Mode Rejection
  - 20 kV/µs Minimum Common Mode Rejection
- High Speed
  - 20 Mbit/s Date Rate (NRZ)
  - 55 ns Maximum Propagation Delay
  - 20 ns Maximum Pulse Width Distortion
  - 30 ns Maximum Propagation Delay Skew
- 3.3 V and 5 V CMOS Compatibility
- Specifications Guaranteed Over 3 V to 5.5 V Supply Voltage and -40°C to +110°C Temperature Range
- Safety and Regulatory Approvals:
  - UL1577, 3750 VAC<sub>RMS</sub> for 1 Minute
  - DIN EN/IEC60747-5-5

### **Applications**

- Microprocessor System Interface:
  - SPI, I<sup>2</sup>C
- Industrial Fieldbus Communications:
  - DeviceNet, CAN, RS485
- Programmable Logic Control
- Isolated Data Acquisition System
- Voltage Level Translator

### Description

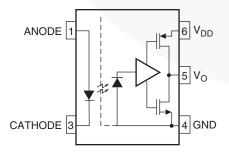
The FODM8071 is a 3.3V/5V high-speed logic gate output optocoupler, which supports isolated communications allowing digital signals to communicate between systems without conducting ground loops or hazardous voltages. It utilizes Fairchild's patented coplanar packaging technology, Optoplanar®, and optimized IC design to achieve high-immunity, characterized by high common mode rejection specifications.

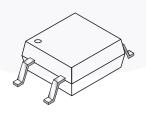
This high-speed logic gate output optocoupler, housed in a compact 5-pin Mini-Flat package, consists of a highspeed AlGaAs LED at the input coupled to a CMOS detector IC at the output. The detector IC comprises an integrated photodiode, a high-speed transimpedance amplifier and a voltage comparator with an output driver. The CMOS technology coupled with a high-efficiency LED achieves low power consumption as well as very high speed (55 ns propagation delay, 20 ns pulse width distortion).

#### **Related Resources**

- FOD8001 Product Folder
- FOD0721 Product Folder

### Schematic and Package Outline





Truth Table

| LED | Output |
|-----|--------|
| Off | High   |
| On  | Low    |

Figure 1. Schematic and Package Outline

### **Safety and Insulation Ratings**

As per DIN EN/IEC 60747-5-5, this optocoupler is suitable for "safe electrical insulation" only within the safety limit data. Compliance with the safety ratings shall be ensured by means of protective circuits.

| Parameter                                  |                        | Characteristics |
|--|------------------------|-----------------|
| Installation Classifications per DIN VDE   | < 150 V <sub>RMS</sub> | I–IV            |
| 0110/1.89 Table 1, For Rated Mains Voltage | < 300 V <sub>RMS</sub> | I–III           |
| Climatic Classification                    |                        | 40/110/21       |
| Pollution Degree (DIN VDE 0110/1.89)       |                        | 2               |
| Comparative Tracking Index                 |                        | 175             |

| Symbol                | Parameter  | Value | Unit              |
|-----------------------|--|-------|-------------------|
| V                     | Input-to-Output Test Voltage, Method A, $V_{IORM} \times 1.6 = V_{PR}$ , Type and Sample Test with $t_m = 10$ s, Partial Discharge < 5 pC  | 904   | V <sub>peak</sub> |
| V <sub>PR</sub>       | Input-to-Output Test Voltage, Method B, $V_{IORM} \times 1.875 = V_{PR}$ , 100% Production Test with $t_m = 1$ s, Partial Discharge < 5 pC | 1060  | V <sub>peak</sub> |
| V <sub>IORM</sub>     | Maximum Working Insulation Voltage   | 565   | V <sub>peak</sub> |
| V <sub>IOTM</sub>     | Highest Allowable Over-Voltage   | 4000  | V <sub>peak</sub> |
|                       | External Creepage  | ≥ 5   | mm                |
|                       | External Clearance   | ≥ 5   | mm                |
| DTI                   | Distance Through Insulation (Insulation Thickness)   | ≥ 0.4 | mm                |
| T <sub>S</sub>        | Case Temperature <sup>(1)</sup>  | 150   | °C                |
| I <sub>S,INPUT</sub>  | Input Current <sup>(1)</sup>   | 200   | mA                |
| P <sub>S,OUTPUT</sub> | Output Power <sup>(1)</sup>  | 300   | mW                |
| R <sub>IO</sub>       | Insulation Resistance at T <sub>S</sub> , V <sub>IO</sub> = 500 V <sup>(1)</sup>   | > 109 | Ω                 |

#### Note:

1. Safety limit values – maximum values allowed in the event of a failure.

#### **Pin Definitions**

| Number | Name            | Function Description  |
|--------|-----------------|-----------------------|
| 1      | ANODE           | Anode                 |
| 3      | CATHODE         | Cathode               |
| 4      | GND             | Output Ground         |
| 5      | V <sub>O</sub>  | Output Voltage        |
| 6      | V <sub>DD</sub> | Output Supply Voltage |

### **Absolute Maximum Ratings**

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.  $T_A = 25^{\circ}$ C unless otherwise specified.

| Symbol           | Parameter   | Value                         | Unit |
|------------------|---|-------------------------------|------|
| T <sub>STG</sub> | Storage Temperature   | -40 to +125                   | °C   |
| T <sub>OPR</sub> | Operating Temperature   | -40 to +110                   | °C   |
| TJ               | Junction Temperature  | -40 to +125                   | °C   |
| T <sub>SOL</sub> | Lead Solder Temperature (Refer to Reflow Temperature Profile) | 260 for 10 seconds            | °C   |
| I <sub>F</sub>   | Forward Current   | 20                            | mA   |
| V <sub>R</sub>   | Reverse Voltage   | 5                             | V    |
| V <sub>DD</sub>  | Supply Voltage  | 0 to 6.0                      | V    |
| Vo               | Output Voltage  | -0.5 to V <sub>DD</sub> + 0.5 | V    |
| Io               | Average Output Current  | 10                            | mA   |
| PDI              | Input Power Dissipation <sup>(2)(4)</sup>                     | 40                            | mW   |
| PD <sub>O</sub>  | Output Power Dissipation <sup>(3)(4)</sup>                    | 70                            | mW   |

#### Notes:

- 2. Derate linearly from 95°C at a rate of -1.4 mW/°C
- 3. Derate linearly from 100°C at a rate of -3.47 mW/°C.
- 4. Functional operation under these conditions is not implied. Permanent damage may occur if the device is subjected to conditions outside these ratings.

### **Recommended Operating Conditions**

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to Absolute Maximum Ratings.

| Symbol          | Parameter                      | Min. | Max. | Unit |
|-----------------|--------------------------------|------|------|------|
| T <sub>A</sub>  | Ambient Operating Temperature  | -40  | +110 | °C   |
| V <sub>DD</sub> | Supply Voltages <sup>(5)</sup> | 3.0  | 5.5  | V    |
| V <sub>FL</sub> | Logic Low Input Voltage        | 0    | 0.8  | V    |
| I <sub>FH</sub> | Logic High Input Current       | 5    | 16   | mA   |
| I <sub>OL</sub> | Logic Low Output Current       | 0    | 7    | mA   |

#### Note:

5. 0.1µF bypass capacitor must be connected between 4 and 6.

#### **Electrical Characteristics**

Apply over all recommended conditions.  $T_A$  = -40°C to +110°C, 3.0 V  $\leq$  V<sub>DD</sub>  $\leq$  5.5 V, unless otherwise specified. Typical value is measured at  $T_A$  = 25°C and V<sub>DD</sub> = 3.3 V.

| Symbol           | Parameter   | Test Conditions  | Min.                    | Тур.   | Max. | Unit |
|------------------|---|--|-------------------------|--------|------|------|
| INPUT C          | INPUT CHARACTERISTICS                               |  |                         |        | 1    |      |
| V <sub>F</sub>   | Forward Voltage                                     | I <sub>F</sub> = 10 mA (Figure 2)                                      | 1.05                    | 1.35   | 1.8  | V    |
| BV <sub>R</sub>  | Input Reverse<br>Breakdown Voltage                  | Ι <sub>R</sub> = 10 μΑ   | 5                       | 15     |      | V    |
| I <sub>FHL</sub> | Threshold Input<br>Current                          | (Figure 3)   |                         | 2.8    | 5.0  | mA   |
| OUTPUT           | CHARACTERISTICS                                     |  | •                       |        | •    | •    |
|                  | I <sub>DDL</sub> Logic Low Output<br>Supply Current | V <sub>DD</sub> = 3.3 V, I <sub>F</sub> = 10 mA<br>(Figures 4 and 6)   |                         | 3.3    | 4.8  | mA   |
| 'DDL             |   | V <sub>DD</sub> = 5.0 V, I <sub>F</sub> = 10 mA<br>(Figures 4 and 7)   |                         | 4.0    | 5.0  | mA   |
|                  | Logic High Output                                   | $V_{DD} = 3.3 \text{ V}, I_F = 0 \text{ mA (Figure 5)}$                |                         | 3.3    | 4.8  | mA   |
| I <sub>DDH</sub> | Supply Current                                      | $V_{DD} = 5.0 \text{ V}, I_F = 0 \text{ mA (Figure 5)}$                |                         | 4.0    | 5.0  | mA   |
|                  |   | $V_{DD} = 3.3 \text{ V}, I_{O} = -20 \mu\text{A}, I_{F} = 0 \text{mA}$ | V <sub>DD</sub> – 0.1 V | 3.3    |      | V    |
| \/               | Logic High Output                                   | $V_{DD} = 3.3 \text{ V}, I_{O} = -4 \text{ mA}, I_{F} = 0 \text{ mA}$  | V <sub>DD</sub> – 0.5 V | 3.1    |      | V    |
| V <sub>OH</sub>  | Voltage   | $V_{DD} = 5.0 \text{ V}, I_{O} = -20 \mu\text{A}, I_{F} = 0 \text{mA}$ | V <sub>DD</sub> – 0.1 V | 5.0    |      | V    |
|                  |   | $V_{DD} = 5.0 \text{ V}, I_{O} = -4 \text{ mA}, I_{F} = 0 \text{ mA}$  | V <sub>DD</sub> – 0.5 V | 4.9    |      | V    |
| \/               | Logic Low Output                                    | I <sub>O</sub> = 20 μA, I <sub>F</sub> = 10 mA                         |                         | 0.0027 | 0.01 | V    |
| V <sub>OL</sub>  | Voltage   | I <sub>O</sub> = 4 mA, I <sub>F</sub> = 10 mA                          |                         | 0.27   | 0.80 | V    |

#### **Electrical Characteristics** (Continued)

Apply over all recommended conditions.  $T_A$  = -40°C to +110°C, 3.0 V  $\leq$  V<sub>DD</sub>  $\leq$  5.5 V, unless otherwise specified. Typical value is measured at  $T_A$  = 25°C and V<sub>DD</sub> = 3.3 V.

#### **Switching Characteristics**

| Symbol                   | Parameter   | Test Conditions  | Min. | Тур. | Max. | Unit  |
|--------------------------|---|--|------|------|------|-------|
| Date Rate <sup>(6)</sup> |   |  |      |      | 20   | Mbps  |
| t <sub>PW</sub>          | Pulse Width   |  | 50   |      |      | ns    |
| t <sub>PHL</sub>         | Propagation Delay Time to Logic Low Output                        | C <sub>L</sub> = 15 pF<br>(Figures 8, 9, and 13)   |      | 31   | 55   | ns    |
| t <sub>PLH</sub>         | Propagation Delay Time to Logic High Output                       | C <sub>L</sub> = 15 pF<br>(Figures 8, 9, and 13)   |      | 25   | 55   | ns    |
| PWD                      | Pulse Width Distortion,<br>  t <sub>PHL</sub> - t <sub>PLH</sub>  | C <sub>L</sub> = 15 pF<br>(Figures 10 and 11)  |      | 5.5  | 20   | ns    |
| t <sub>PSK</sub>         | Propagation Delay Skew  | $C_L = 15 \text{ pF}^{(7)}$  |      |      | 30   | ns    |
| t <sub>R</sub>           | Output Rise Time (10% to 90%)                                     | (Figure 12 and 13)   |      | 5.8  |      | ns    |
| t <sub>F</sub>           | Output Fall Time<br>(90% to 10%)                                  | (Figure 12 and 13)   |      | 5.3  |      | ns    |
| CM <sub>H</sub>          | Common Mode Transient<br>Immunity at Output High                  | $I_F = 0 \text{ mA}, V_O > 0.8 V_{DD},$<br>$V_{CM} = 1000 \text{ V}, T_A = 25^{\circ}\text{C},$<br>(Figure 14) <sup>(8)</sup>    | 20   | 40   |      | kV/μs |
| CM <sub>L</sub>          | Common Mode Transient<br>Immunity at Output Low                   | $I_F = 5 \text{ mA}, V_O < 0.8 \text{ V},$<br>$V_{CM} = 1000 \text{ V}, T_A = 25^{\circ}\text{C},$<br>(Figure 14) <sup>(8)</sup> | 20   | 40   |      | kV/μs |
| C <sub>PDO</sub>         | Output Dynamic Power<br>Dissipation<br>Capacitance <sup>(9)</sup> |  |      | 4    |      | pF    |

#### Notes:

- 6. Data rate is based on 10 MHz, 50% NRZ pattern with a 50 nsec minimum bit time.
- 7.  $t_{PSK}$  is equal to the magnitude of the worst case difference in  $t_{PHL}$  and/or  $t_{PLH}$  that will be seen between any two units from the same manufacturing date code that are operated at same case temperature (±5°C), at the same operating conditions, with equal loads ( $R_L = 350~\Omega$  and  $C_L = 15~pF$ ), and with an input rise time less than 5 ns.
- 8. Common mode transient immunity at output high is the maximum tolerable positive dVcm/dt on the leading edge of the common mode impulse signal, Vcm, to assure that the output will remain high. Common mode transient immunity at output low is the maximum tolerable negative dVcm/dt on the trailing edge of the common pulse signal, Vcm, to assure that the output will remain low.
- Unloaded dynamic power dissipation is calculated as follows: C<sub>PD</sub> x V<sub>DD</sub> x f + I<sub>DD</sub> + V<sub>PD</sub> where f is switched time in MHz.

#### **Isolation Characteristics**

| Symbol           | Parameter                         | Conditions  | Min.             | Тур. | Max. | Unit               |
|------------------|-----------------------------------|---|------------------|------|------|--------------------|
| V <sub>ISO</sub> | Input-Output Isolation<br>Voltage | $I_{I-O} \le 10 \ \mu A^{(10)(11)}$                 | 3750             |      |      | Vac <sub>RMS</sub> |
| R <sub>ISO</sub> | Isolation Resistance              | $V_{I-O} = 500 V^{(10)}$                            | 10 <sup>11</sup> |      |      | Ω                  |
| C <sub>ISO</sub> | Isolation Capacitance             | $V_{I-O} = 0 \text{ V, f} = 1.0 \text{ MHz}^{(10)}$ |                  | 0.2  |      | pF                 |

#### Notes:

- 10.Device is considered a two terminal device: pins 1, and 3 are shorted together and pins 4, 5, and 6 are shorted together.
- 11.3,750 VAC<sub>RMS</sub> for 1 minute duration is equivalent to 4,500 VAC<sub>RMS</sub> for 1 second duration.

### **Typical Performance Curves**

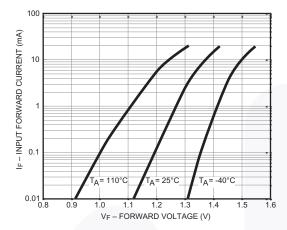


Figure 2. Input Forward Current vs. Forward Voltage

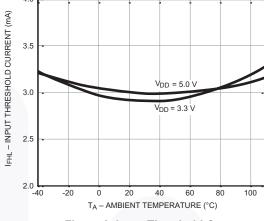


Figure 3. Input Threshold Current vs. Ambient Temperature

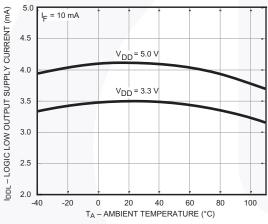


Figure 4. Logic Low Output Supply Current vs. Ambient Temperature

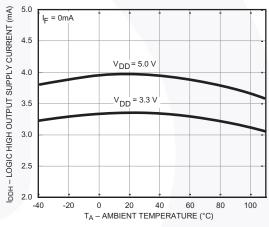


Figure 5. Logic High Output Supply Current vs. Ambient Temperature

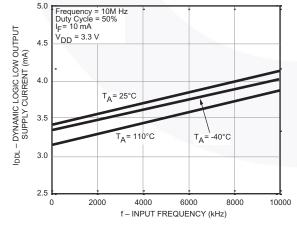


Figure 6. Dynamic Logic Low Output Supply Current vs. Input Frequency (V<sub>DD</sub> = 3.3V)

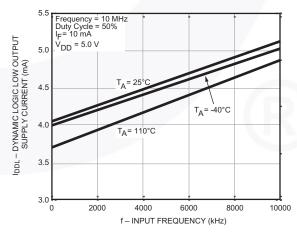


Figure 7. Dynamic Logic Low Output Supply Current vs. Input Frequency (V<sub>DD</sub> = 5.0V)

### Typical Performance Curves (Continued)

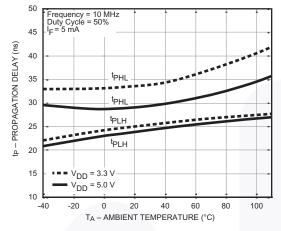


Figure 8. Propagation Delay vs. Ambient Temperature

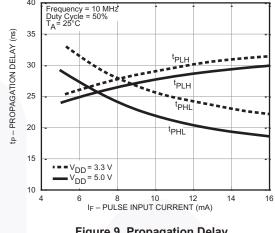


Figure 9. Propagation Delay vs. Pulse Input Current

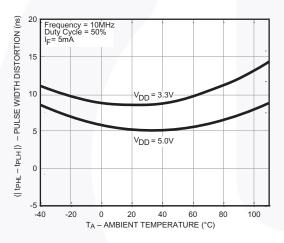


Figure 10. Pulse Width Distortion vs. Ambient Temperature

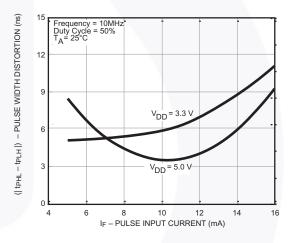


Figure 11. Pulse Width Distortion vs Pulse Input Current

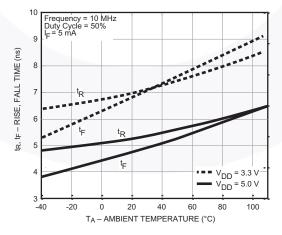


Figure 12. Rise and Fall Time vs. Ambient Temperature

#### **Schematics**

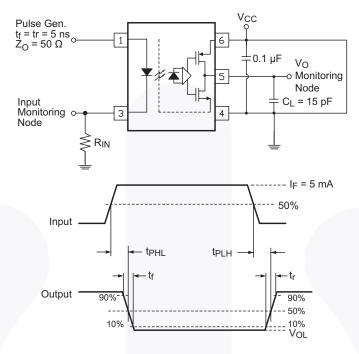
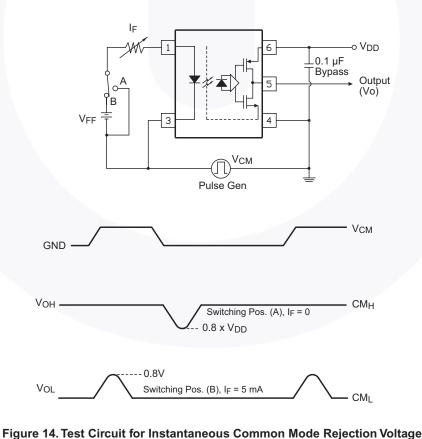


Figure 13. Test Circuit for Propagation Delay Time, Rise Time and Fall Time



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#### **Reflow Profile**

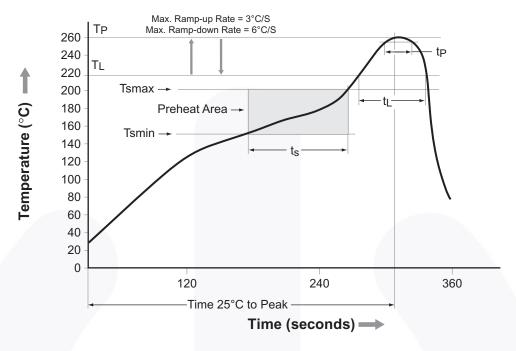


Figure 15. Reflow Profile

| Profile Feature   | Pb-Free Assembly Profile |  |
|---|--------------------------|--|
| Temperature Min. (Tsmin)                                  | 150°C                    |  |
| Temperature Max. (Tsmax)                                  | 200°C                    |  |
| Time (t <sub>S</sub> ) from (Tsmin to Tsmax)              | 60-120 seconds           |  |
| Ramp-up Rate (t <sub>L</sub> to t <sub>P</sub> )          | 3°C/second maximum       |  |
| Liquidous Temperature (T <sub>L</sub> )                   | 217°C                    |  |
| Time (t <sub>L</sub> ) Maintained Above (T <sub>L</sub> ) | 60-150 seconds           |  |
| Peak Body Package Temperature                             | 260°C +0°C / -5°C        |  |
| Time (t <sub>P</sub> ) within 5°C of 260°C                | 30 seconds               |  |
| Ramp-down Rate (T <sub>P</sub> to T <sub>L</sub> )        | 6°C/second maximum       |  |
| Time 25°C to Peak Temperature                             | 8 minutes maximum        |  |

### **Ordering Information**

| Part Number | Package                                     | Packing Method             |
|-------------|---|----------------------------|
| FODM8071    | Mini-Flat 5-Pin                             | Tube (100 Units)           |
| FODM8071R2  | Mini-Flat 5-Pin                             | Tape and Reel (2500 Units) |
| FODM8071V   | Mini-Flat 5-Pin, DIN EN/IEC60747-5-5 Option | Tube (100 Units)           |
| FODM8071R2V | Mini-Flat 5-Pin, DIN EN/IEC60747-5-5 Option | Tape and Reel (2500 Units) |



All packages are lead free per JEDEC: J-STD-020B standard.

### **Marking Information**

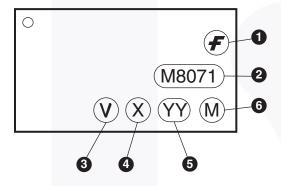
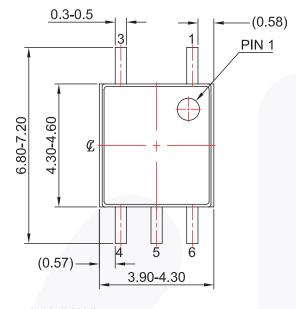


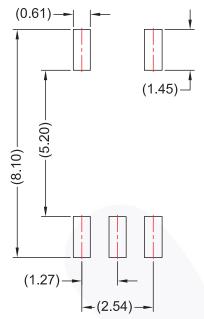
Figure 16. Top Mark

#### **Table 1. Top Mark Definitions**

| 1 | Fairchild Logo  |
|---|---|
| 2 | Device Number   |
| 3 | DIN EN/IEC60747-5-5 Option (only appears on component ordered with this option) |
| 4 | One-Digit Year Code, e.g., "4"  |
| 5 | Digit Work Week, Ranging from "01" to "53"                                      |
| 6 | Assembly Package Code   |

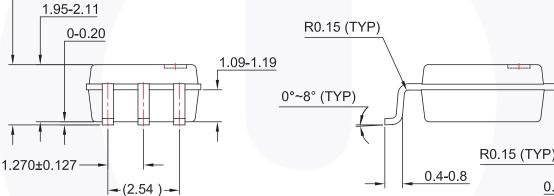
### **Package Dimensions**





2.40 (MAX)

LAND PATTERN RECOMMENDATION



NOTES:

- A) NO STANDARD APPLIES TO THIS PACKAGE
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSION
- D) DWG FILENAME AND REVSION: MKT-MFP05Arev3.



Figure 17. MLP 5L Package

0.18-0.25





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SYSTEM SYSTEM

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TriFault Detect™ TRUECURRENT®\* uSerDes™

UHC

Ultra FRFET™ UniFET™ VCX™ VisualMax™ VoltagePlus™ XSTM. Xsens™ 仙童™

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